

4096 x 1-BIT STATIC RAM

Processed to MIL-STD-883, Method 5004, Class B

MKB4104 (P/J/E)-84/85

FEATURES

- □ Extended operating temperature range (-55°C ≤ T_A ≤ 125°C)
- Combination static storage cells and dynamic control circuitry for truly high performance

Part Number	Access Time	Cycle Time
4104(J)-84	250ns	385ns
4104(J)-85	300ns	510ns

☐ Average power dissipation less than 150mW

- ☐ Standby power dissipation less than 53mW
- ☐ Single +5V power supply (5% tolerance)
- ☐ Fully TTL compatible

Fanout:

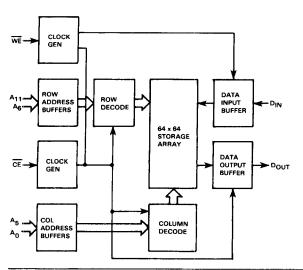
- 2 Standard TTL
 - 2 Schottky TTL
- 12 Low Power Schottky TTL
- ☐ Standard 18 pin DIP
- Leadless chip carrier (E package) available for high density applications
- ☐ Ruggedized for use in severe military environments

DESCRIPTION

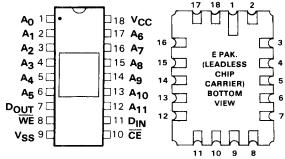
The Mostek MKB4104 is a high performance static random access memory organized as 4096 one bit words. The MKB4104 combines the best characteristics of static and dynamic memory techniques to achieve a TTL compatible, 5 volt only, high performance, low

power memory device. It utilizes advanced circuit design concepts and an innovative state-of-the-art N-channel silicon gate process specially tailored to provide static data storage with the performance (speed and power) of dynamic RAMs. Since the storage cell is static the device may be stopped indefinitely with the CE clock in the off (Logic 1) state.

FUNCTIONAL DESCRIPTION



PIN CONNECTIONS



PIN NAMES

AO-A11 Address Inputs
CE Chip Enable
DIN Data Input
DOUT Data Output

V_{SS} Ground V_{CC} Power (+5V) WE Write Enable

MILITARY HI-REL PRODUCTS

ABSOLUTE MAXIMUM RATINGS*

Voltage on any pin relative to VSS	1.0V to +7.0V
Operating Temperature T _A (Ambient)	55°C to +125°C
Storage Temperature (Ambient)(Ceramic)	-65°C to +150°C
Power Dissipation	1 Watt
Short Circuit Output Current	50mA

*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operation sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability

RECOMMENDED DC OPERATING CONDITIONS⁶

 $(-55^{\circ}C \leq T_{\Delta} \leq +125^{\circ}C)$

SYM	PARAMETER	MIN	TYP	MAX	UNITS	NOTES
V _{CC}	Supply Voltage	4.75	5.0	5.25	V	1
V _{SS}	Supply Voltage	0	0	0	V	1
V _{IH}	Logic "1" Voltage All Inputs	2.4		7.0	V	1
V _{IL}	Logic "O" Voltage All Inputs	-1.0		.65	V	1

DC ELECTRICAL CHARACTERISTICS

 $(-55^{\circ}C \le T_{A} \le +125^{\circ}C) (V_{CC} = 5.0 \text{ volts} \pm 5\%)$

SYM	PARAMETER	MIN	MAX	UNITS	NOTES
I _{CC1}	Average V _{CC} Power Supply Current		27	mA	2
Icc2	Standby V _{CC} Power Supply Current		10	mA	3
liF	Input Leakage Current (Any Input)	-10	10	μА	4
lOL	Output Leakage Current	-10	10	μА	3,5
Vон	Output Logic "1" Voltage I _{OUT} = -500μA	2.4		V	11
VOL	Output Logic "-" Voltage I _{OUT} = 5mA		0.4	V	11

AC ELECTRICAL CHARACTERISTICS

 $(-55^{\circ}C \le T_{A} \le +125^{\circ}C) (V_{CC} = +5.0 \text{ volts} \pm 5\%)$

SYM	PARAMETER	MIN	TYP	MAX	NOTES
Cl	Input Capacitance		4pF	6pF	14
СО	Output Capacitance		7pF	7pF	14

NOTES:

- All voltages referenced to VSS
- ICC1 is related to precharge and cycle times. Guaranteed maximum values for ICC1 are at minimum cycle time
- Output is disabled (open circuit). CE is at logic 1
- All device pins at 0 volts except pin under test at 0 V_{IN} 5 5V (V_{CC} 5V)
- OV · V_{OUT} · · · 5 5V (V_{CC} 5V)

 During power up, CE and WE must be at V_{IH} for minimum of 2ms after V_{CC}
- reaches 4 75V, before a valid memory cycle can be accomplished Measured with load circuit equivalent to 2 TTL loads and CL 100pF
- If WE follows after CE by more than tws, then data out may not remain
- Determined by user. Total cycle time cannot exceed top max

- 10. Data-in set-up time is referenced to the later of the two failing clock edges CE or WE
- AC measurements assume t₁ 5ns. Timing points are taken at 8V and 2 OV on inputs and .8V and 2 OV on the output Transition times are also taken between these levels
- 12 to tol tp . 2tj
- The true level of the output in the open circuit condition will be determined totally by output load conditions. The output is guaranteed to be open circuit within tOFF
- 14 Effective capacitance calculated from the equation C 1∆t with △V equal to 3V and $V_{\mbox{\footnotesize{CC}}}$ nominal.
- 15 For RMW, ICE TAC TWPL TO SMOD
 16 IC TAC TWPL TP 31 TMOD

AC ELECTRICAL CHARACTERISTICS AND RECOMMENDED OPERATING CONDITIONS⁶,¹¹

 $(-55^{\circ}C \le T_{A} \le +125^{\circ}C) (V_{CC} = +5.0 \text{ Volts} \pm 5\%)$

SYM	PARAMETER	МКВ4	MKB4104-84		MKB4104-85		
		MIN	MAX	MIN	MAX	UNITS	NOTES
t _C	Read or Write Cycle Time		410	510		ns	12
^t AC	Random Access		250		300	ns	7
^t CE	Chip Enable Pulse Width	250	5000	300	5000	ns	15
tp	Chip Enable Precharge Time	150		200		ns	
^t AH	Address Hold Time	135		165		ns	
t _{AS}	Address Set-Up Time	0		0		ns	
^t OFF	Output Buffer Turn-Off Delay	0	65	0	75	ns	13
tws	Write Enable Set-Up Time	0		0		ns	8
^t DHC	Data Input Hold Time Referenced to CE	210		250		ns	
^t DHW	Data Input Hold Time Referenced to WE	90		105			
tww	Write Enabled Pulse Width	60		90		ns	
tMOD	Modify Time	0	5000	0	5000	ns	9
tWPL	WE to CE Precharge Lead Time	85		105		ns	10
^t DS	Data Input Set-Up Time	0		0		ns	
t _{WH}	Write Enable Hold Time	185		225		ns	
tŢ	Transition Time	5	50	5	50	ns	
tRMW	Read-Modify-Write Cycle Time	500		620		ns	16
tRS	Read Set-Up Time	0		0		ns	

DESCRIPTION (Continued)

All input levels, including write enable (\overline{WE}) and chip enable (\overline{CE}) are TTL with a one level of 2.4 volts and a zero level of .65 volts. The push-pull output (no pull-up resistor required) delivers a one level of 2.4V minimum and a zero level of .4 volts maximum. The output has a fanout of 2 standard TTL loads or 12 low power Schottky loads.

The RAM employs an innovative static cell which occupies a mere 2.75 square mils (½ the area of previous cells) and dissipates power levels comparable to CMOS. The static cell eliminates the need for refresh cycles and associated hardware thus allowing easy system implementation.

Power supply requirement of +5V combined with TTL compatibility on all I/O pins permits easy integration into large memory configurations. The single supply reduces capacitor count and permits denser packaging on printed circuit boards. The 5V only supply requirement and TTL compatible I/O makes this part an ideal choice for next generation +5V only microprocessors such as Mostek's Z80. The early write mode (WE active prior to CE) permits common I/O operation, needed for Z80 interfacing, without external circuitry.

Reliability is greatly enhanced by the low power dissipation which causes a maximum junction rise of only 6.6° at 1.6 Megahertz operation. The MKB4104 was designed for the system designer and user who require the highest performance available along with Mostek's proven reliability.

